

Features

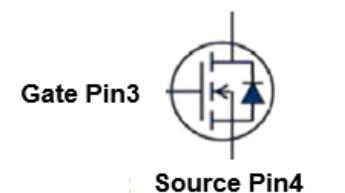
- N-Channel, 5V Logic Level Control
- Enhancement mode
- Fast Switching
- High Effective
- Pb-free lead plating; RoHS compliant; Hg-Free

V_{DS}	100	V
$R_{DS(on),TYP} @ V_{GS}=10\text{ V}$	153	$\text{m}\Omega$
$R_{DS(on),TYP} @ V_{GS}=4.5\text{ V}$	162	$\text{m}\Omega$
I_D	2.2	A

SOT23-6L

Halogen-Free

Part ID	Package Type	Marking	Tape and reel information
VSH160N10MS	SOT23-6L	VS09	3000pcs/reel



Maximum ratings, at $T_j=25\text{ }^\circ\text{C}$, unless otherwise specified

Symbol	Parameter	Rating	Unit
$V_{(BR)DSS}$	Drain-Source breakdown voltage	100	V
I_s	Diode continuous forward current	$T_c=25\text{ }^\circ\text{C}$	A
I_D	Continuous drain current@ $V_{GS}=10\text{ V}$	$T_c=25\text{ }^\circ\text{C}$	A
		$T_c=100\text{ }^\circ\text{C}$	A
I_{DM}	Pulse drain current tested ①	$T_c=25\text{ }^\circ\text{C}$	A
P_d	Maximum power dissipation	$T_c=25\text{ }^\circ\text{C}$	W
V_{GS}	Gate-Source voltage	± 20	V
T_{STG}	Storage temperature range	-55 to 150	$^\circ\text{C}$

Thermal Characteristics

Symbol	Parameter	Typical	Unit
$R_{\theta JL}$	Thermal Resistance-Junction to Lead	60	$^\circ\text{C/W}$
$R_{\theta JA}$	Thermal Resistance-Junction to Ambient	100	$^\circ\text{C/W}$

Typical Electrical Characteristics

Symbol	Parameter	Condition	Min.	Typ.	Max.	Unit
Static Electrical Characteristics @ $T_J = 25^\circ\text{C}$ (unless otherwise stated)						
$V_{(\text{BR})\text{DSS}}$	Drain-Source Breakdown Voltage	$V_{\text{GS}}=0\text{V}, I_{\text{D}}=250\mu\text{A}$	100	--	--	V
I_{DSS}	Zero Gate Voltage Drain Current($T_c=25^\circ\text{C}$)	$V_{\text{DS}}=100\text{V}, V_{\text{GS}}=0\text{V}$	--	--	1	μA
	Zero Gate Voltage Drain Current($T_c=125^\circ\text{C}$)	$V_{\text{DS}}=100\text{V}, V_{\text{GS}}=0\text{V}$	--	--	100	μA
I_{GSS}	Gate-Body Leakage Current	$V_{\text{GS}}=\pm 20\text{V}, V_{\text{DS}}=0\text{V}$	--	--	± 100	nA
$V_{\text{GS(TH)}}$	Gate Threshold Voltage	$V_{\text{DS}}=V_{\text{GS}}, I_{\text{D}}=250\mu\text{A}$	1.3	1.7	2.4	V
$R_{\text{DS(ON)}}$	Drain-Source On-State Resistance②	$V_{\text{GS}}=10\text{V}, I_{\text{D}}=3\text{A}$	--	153	168	$\text{m}\Omega$
$R_{\text{DS(ON)}}$	Drain-Source On-State Resistance②	$V_{\text{GS}}=4.5\text{V}, I_{\text{D}}=2\text{A}$	--	162	180	$\text{m}\Omega$
Dynamic Electrical Characteristics @ $T_J = 25^\circ\text{C}$ (unless otherwise stated)						
C_{iss}	Input Capacitance	$V_{\text{DS}}=30\text{V}, V_{\text{GS}}=0\text{V}, f=1\text{MHz}$	200	280	350	pF
C_{oss}	Output Capacitance		--	30	80	pF
C_{rss}	Reverse Transfer Capacitance		--	20	70	pF
R_g	Gate Resistance	$f=1\text{MHz}$	--	6.3	--	Ω
Q_q	Total Gate Charge	$V_{\text{DS}}=50\text{V}, I_{\text{D}}=3\text{A}, V_{\text{GS}}=10\text{V}$	--	7	--	nC
Q_{qs}	Gate-Source Charge		--	1.6	--	nC
Q_{qd}	Gate-Drain Charge		--	2	--	nC
Switching Characteristics						
$t_{\text{d(on)}}$	Turn-on Delay Time	$V_{\text{DD}}=50\text{V}, I_{\text{D}}=3\text{A}, R_{\text{G}}=3\Omega, V_{\text{GS}}=10\text{V}$	--	7	--	nS
t_r	Turn-on Rise Time		--	4.5	--	nS
$t_{\text{d(off)}}$	Turn-Off Delay Time		--	18	--	nS
t_f	Turn-Off Fall Time		--	4.5	--	nS
Source- Drain Diode Characteristics@ $T_J = 25^\circ\text{C}$ (unless otherwise stated)						
V_{SD}	Forward on voltage	$I_{\text{SD}}=3\text{A}, V_{\text{GS}}=0\text{V}$	--	0.8	1.2	V
t_{rr}	Reverse Recovery Time	$T_j=25^\circ\text{C}, I_{\text{sd}}=3\text{A}, V_{\text{GS}}=0\text{V}$ $dI/dt=500\text{A}/\mu\text{s}$	--	16	--	nS
Q_{rr}	Reverse Recovery Charge		--	54	--	nC

NOTE:

① Repetitive rating; pulse width limited by max. junction temperature.

② Pulse width $\leq 300\mu\text{s}$; duty cycle $\leq 2\%$.

Typical Characteristics

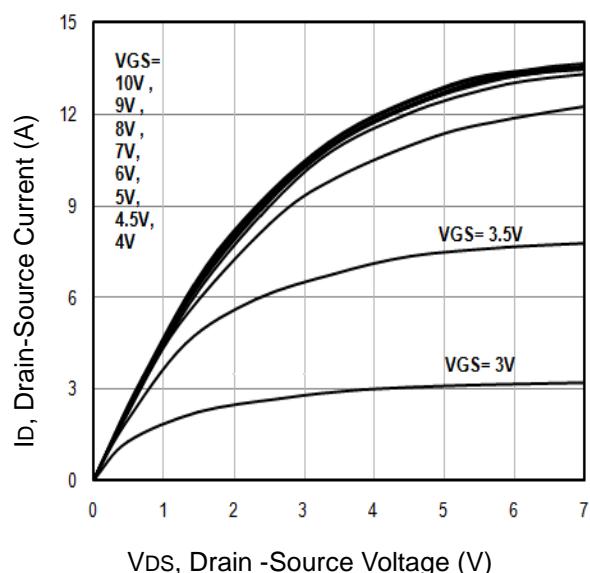


Fig1. Typical Output Characteristics

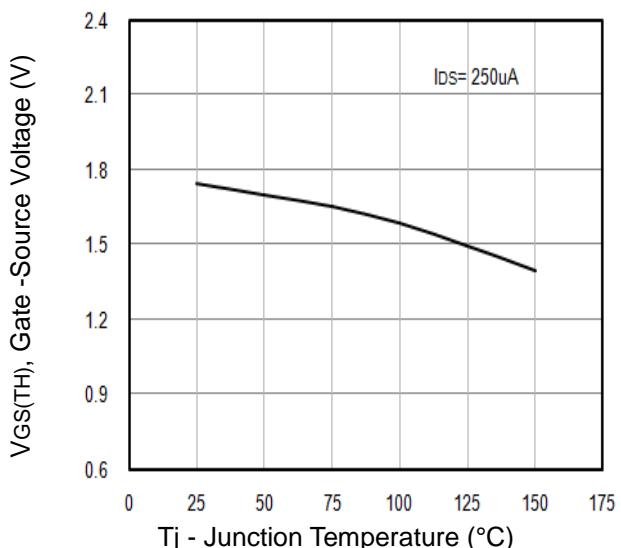


Fig2. Threshold Voltage Vs. Temperature

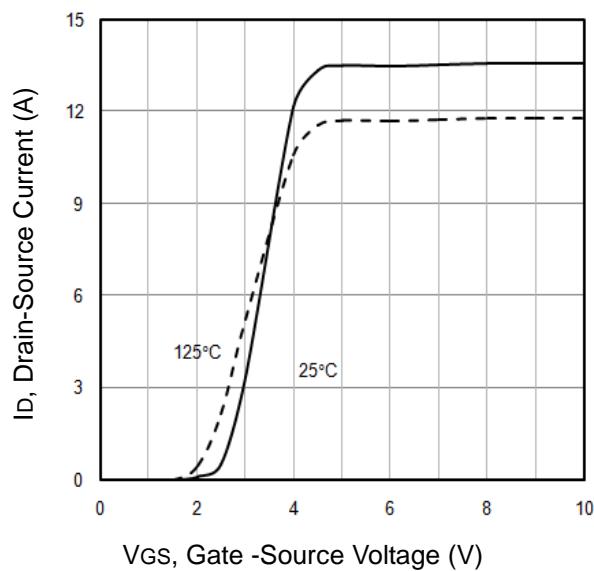


Fig3. Typical Transfer Characteristics

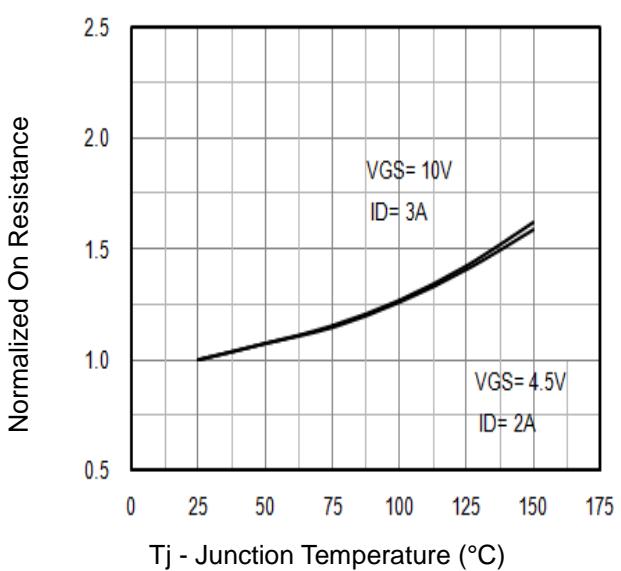


Fig4. Normalized On-Resistance Vs. Temperature

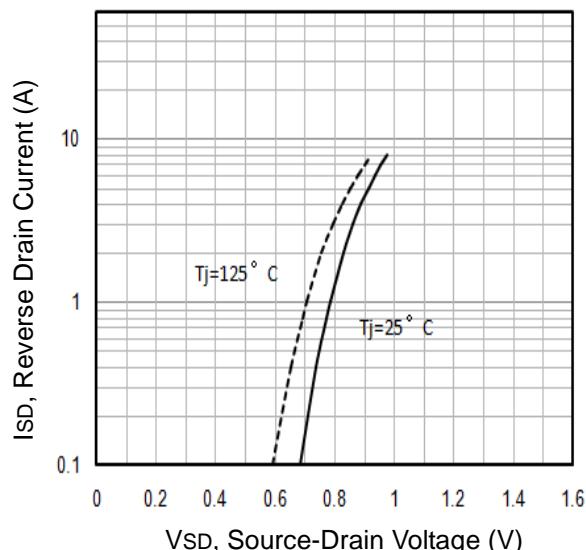


Fig5. Typical Source-Drain Diode Forward Voltage

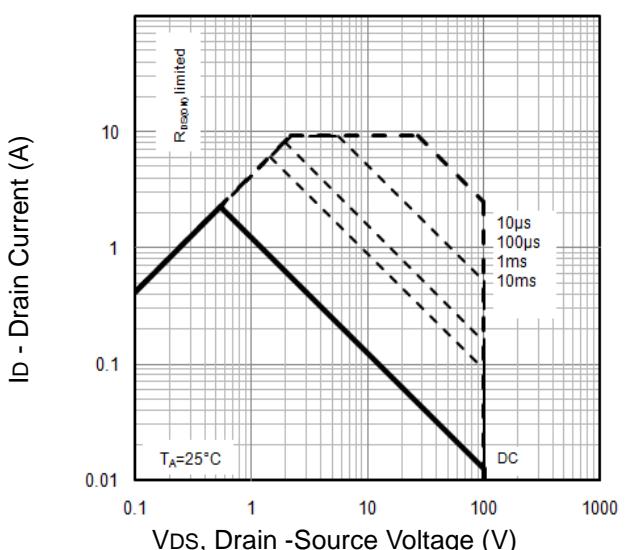


Fig6. Maximum Safe Operating Area

Typical Characteristics

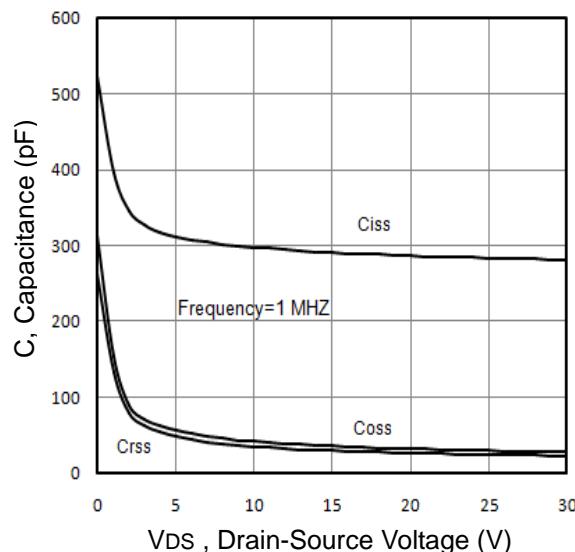


Fig7. Typical Capacitance Vs.Drain-Source Voltage

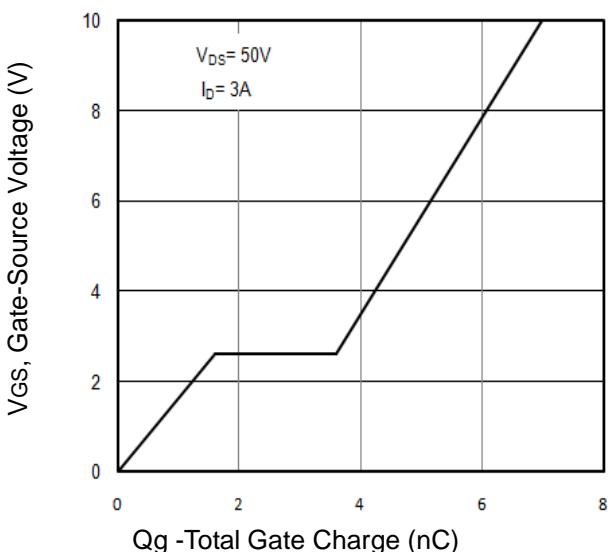
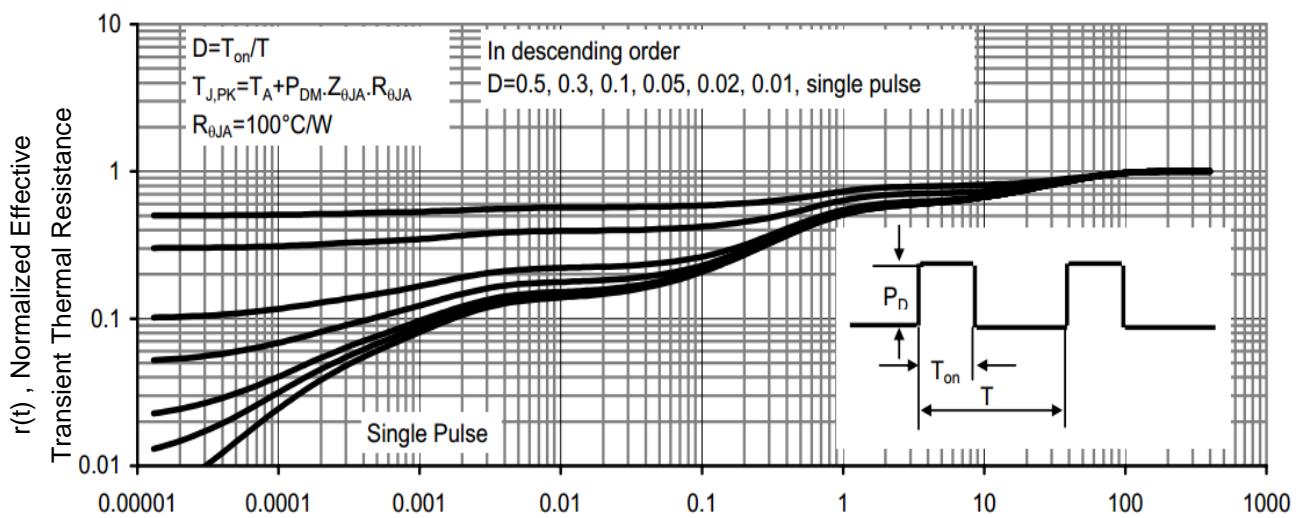


Fig8. Typical Gate Charge Vs.Gate-Source Voltage



T1, Square Wave Pulse Duration(sec)
Fig9. T1 ,Transient Thermal Response Curve

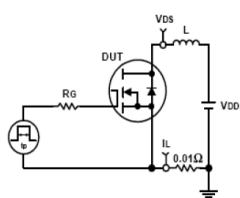


Fig10. Unclamped Inductive Test Circuit and waveforms

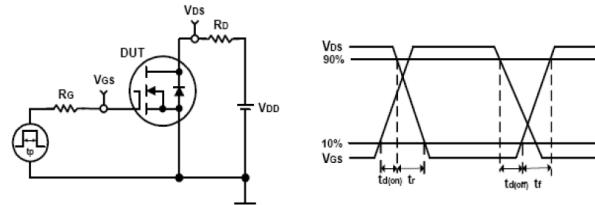
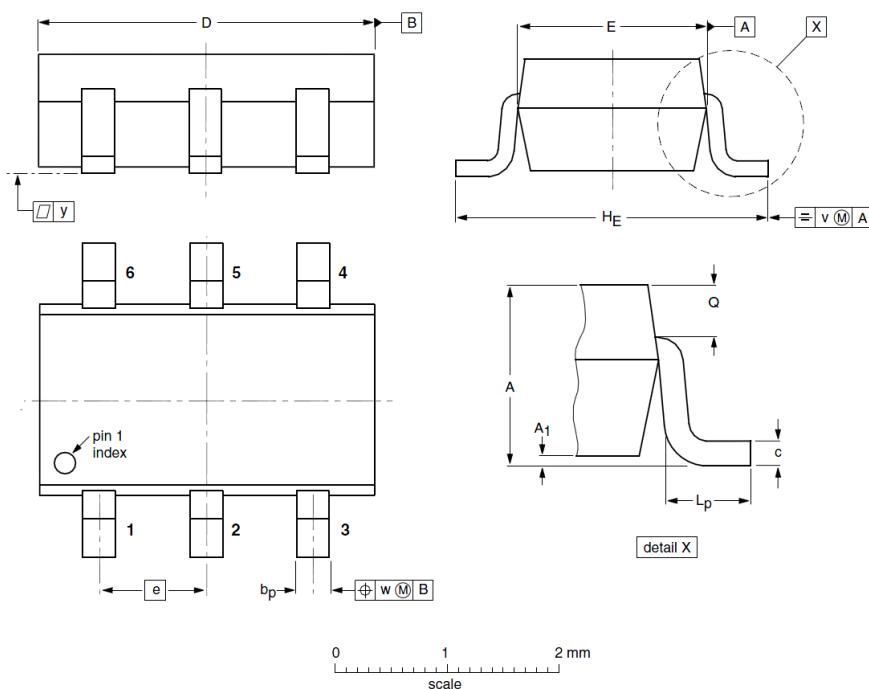


Fig11. Switching Time Test Circuit and waveforms

SOT23-6L Package Outline



Label	Dimensions (unit: mm)		
	Min	Typ	Max
A	0.90	1.07	1.45
b_p	0.30	0.35	0.40
D	2.70	2.92	3.10
e	--	0.95	--
L_p	0.30	0.45	0.60
v	--	0.20	--
y	--	0.10	
A₁	0.01	0.05	0.15
c	0.10	0.15	0.22
E	1.30	1.55	1.70
H_E	2.50	2.80	3.00
Q	0.23	0.29	0.33
w	--	0.20	--

Notes:

- Follow JEDEC MS-012.
- Dimension "D" does NOT include mold flash, protrusions or gate burrs. Mold flash, protrusions or gate burrs shall not exceed 0.15mm per side.
- Dimension "E" does NOT include interlead flash or protrusion. Interlead flash or protrusion shall not exceed 0.25mm per side.
- Dimension "bp" does NOT include dambar protrusion. Allowable dambar protrusion shall be 0.1mm total in excess of "bp" dimension at maximum material condition. The dambar cannot be located on the lower radius of the foot.

Customer Service

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